

Notice of References Cited	Application/Control No. 10/613,058	Applicant(s)/Patent Under Reexamination MAYER ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,684,756	08-1987	Derr et al.	585/330
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	CN 1401427 A	03-2003	China	GAO et al.	B01J 23/75
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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